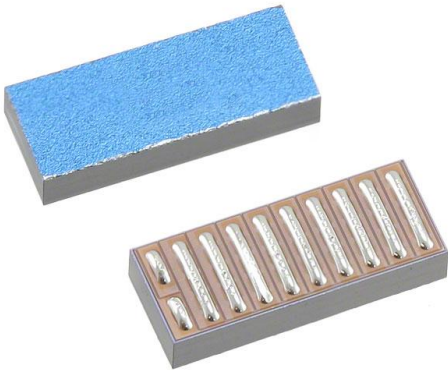


EPC2015 Datasheet

www.digi-electronics.com



<https://www.DiGi-Electronics.com>

DiGi Electronics Part Number	EPC2015-DG
Manufacturer	EPC
Manufacturer Product Number	EPC2015
Description	GANFET N-CH 40V 33A DIE OUTLINE
Detailed Description	N-Channel 40 V 33A (Ta) Surface Mount Die



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

DiGi is a global authorized distributor of electronic components.

Purchase and inquiry

Manufacturer Product Number:

EPC2015

Series:

eGaN®

FET Type:

N-Channel

Drain to Source Voltage (Vdss):

40 V

Drive Voltage (Max Rds On, Min Rds On):

5V

Vgs(th) (Max) @ Id:

2.5V @ 9mA

Vgs (Max):

+6V, -5V

FET Feature:

-

Operating Temperature:

-40°C ~ 150°C (Tj)

Supplier Device Package:

Die

Base Product Number:

EPC20

Manufacturer:

EPC

Product Status:

Discontinued at Digi-Key

Technology:

GaN FET (Gallium Nitride)

Current - Continuous Drain (Id) @ 25°C:

33A (Ta)

Rds On (Max) @ Id, Vgs:

4mOhm @ 33A, 5V

Gate Charge (Qg) (Max) @ Vgs:

11.6 nC @ 5 V

Input Capacitance (Ciss) (Max) @ Vds:

1200 pF @ 20 V

Power Dissipation (Max):

-

Mounting Type:

Surface Mount

Package / Case:

Die

Environmental & Export classification

RoHS Status:

ROHS3 Compliant

REACH Status:

REACH Unaffected

HTSUS:

8541.29.0040

Moisture Sensitivity Level (MSL):

1 (Unlimited)

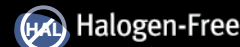
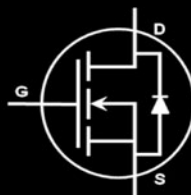
ECCN:

EAR99

EPC2015 – Enhancement Mode Power Transistor

 $V_{DSS}, 40\text{ V}$
 $R_{DS(ON)}, 4\text{ m}\Omega$
 $I_D, 33\text{ A}$

NEW PRODUCT



Gallium Nitride is grown on Silicon Wafers and processed using standard CMOS equipment leveraging the infrastructure that has been developed over the last 55 years. GaN's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(ON)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.



EPC2015 eGaN® FETs are supplied only in passivated die form with solder bars

Applications

- High Speed DC-DC conversion
- Class D Audio
- Hard Switched and High Frequency Circuits

Benefits

- Ultra High Efficiency
- Ultra Low $R_{DS(on)}$
- Ultra low Q_G
- Ultra small footprint

Maximum Ratings			
V_{DS}	Drain-to-Source Voltage (Continuous)	40	V
	Drain-to-Source Voltage (up to 10,000 5ms pulses at 125° C)	48	V
I_D	Continuous ($T_A = 25^\circ\text{C}, \theta_{JA} = 13$)	33	A
	Pulsed (25° C, $T_{\text{pulse}} = 300\ \mu\text{s}$)	150	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-5	
T_J	Operating Temperature	-40 to 150	°C
T_{STG}	Storage Temperature	-40 to 150	

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0\text{ V}, I_D = 500\ \mu\text{A}$	40		V	
I_{DSS}	Drain Source Leakage	$V_{DS} = 32\text{ V}, V_{GS} = 0\text{ V}$		200	400	μA
I_{GSS}	Gate-Source Forward Leakage	$V_{GS} = 5\text{ V}$		1.5	7	mA
	Gate-Source Reverse Leakage	$V_{GS} = -5\text{ V}$		0.3	1.5	
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 9\text{ mA}$	0.7	1.4	2.5	V
$R_{DS(ON)}$	Drain-Source On Resistance	$V_{GS} = 5\text{ V}, I_D = 33\text{ A}$		3.2	4	$\text{m}\Omega$
Source-Drain Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
V_{SD}	Source-Drain Forward Voltage	$I_S = 0.5\text{ A}, V_{GS} = 0\text{ V}, T = 25^\circ\text{C}$		1.75		V
		$I_S = 0.5\text{ A}, V_{GS} = 0\text{ V}, T = 150^\circ\text{C}$		1.8		

All measurements were done with substrate shorted to source.

Thermal Characteristics			
		TYP	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.1	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction to Board	15	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	54	°C/W

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Dynamic Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
C_{ISS}	Input Capacitance	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$		1100	1200	pF
C_{OSS}	Output Capacitance			575	750	
C_{RSS}	Reverse Transfer Capacitance			60	70	
Q_G	Total Gate Charge ($V_{GS} = 5\text{ V}$)	$V_{DS} = 20\text{ V}, I_D = 33\text{ A}$		10.5	11.6	nC
Q_{GD}	Gate to Drain Charge			2.2	2.7	
Q_{GS}	Gate to Source Charge			3	3.5	
Q_{OSS}	Output Charge	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$		18.5	22	
Q_{RR}	Source-Drain Recovery Charge			0	0	

All measurements were done with substrate shorted to source.

Figure 1: Typical Output Characteristics

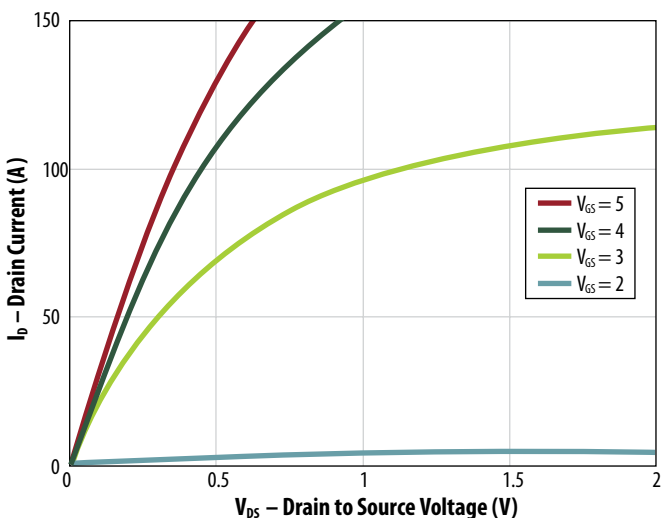


Figure 2: Transfer Characteristics

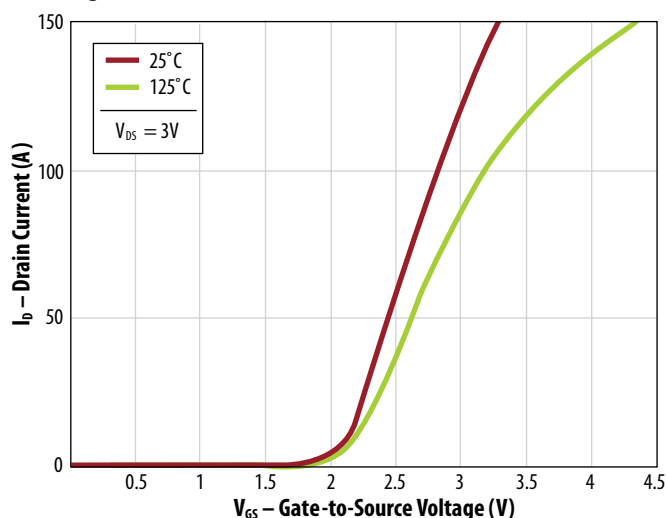


Figure 3: $R_{DS(on)}$ vs V_{GS} for Various Current

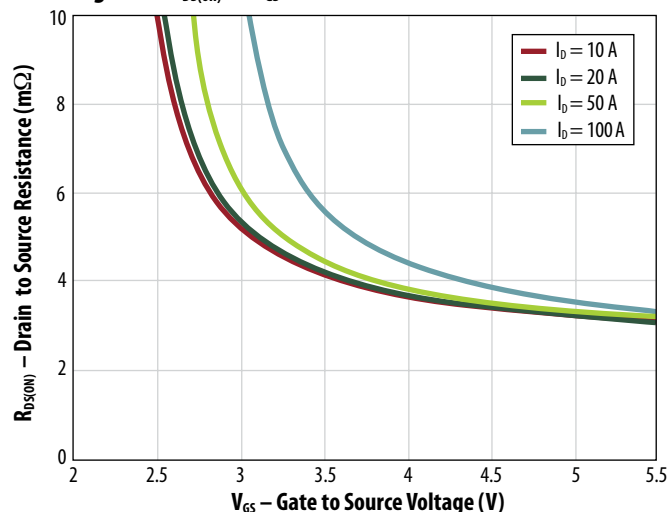


Figure 4: $R_{DS(on)}$ vs V_{GS} for Various Temperature

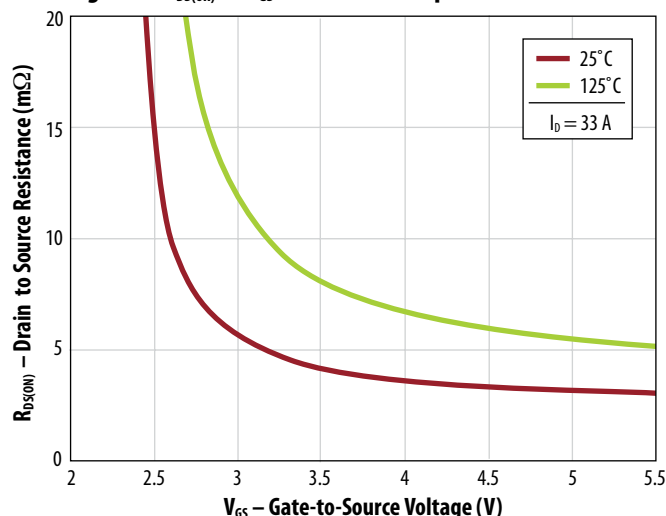


Figure 5: Capacitance

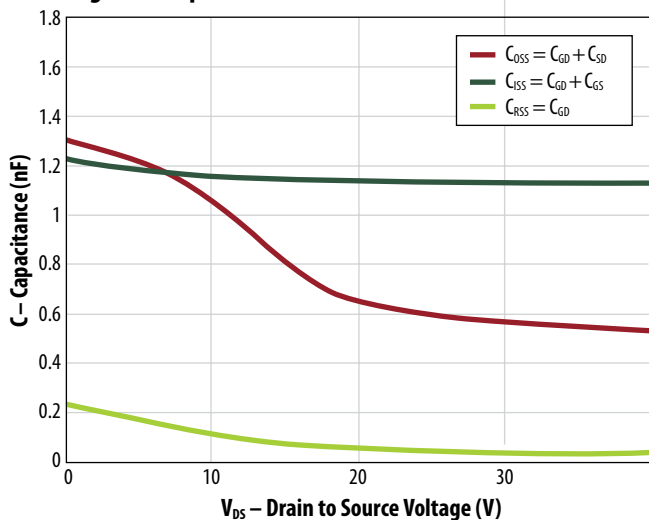


Figure 6: Gate Charge

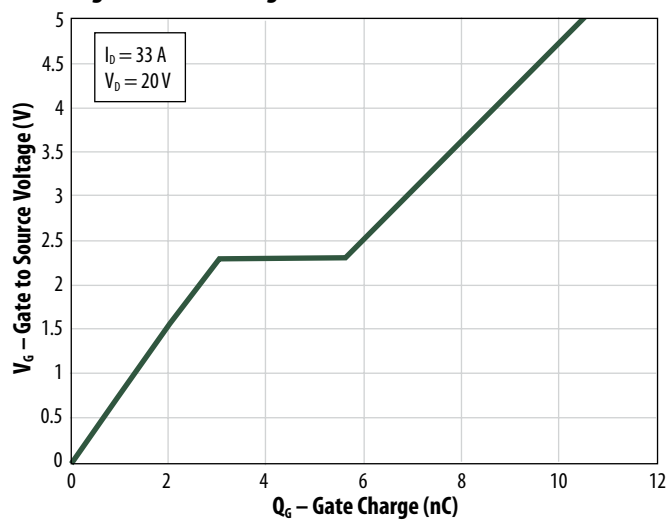


Figure 7: Reverse Drain-Source Characteristics

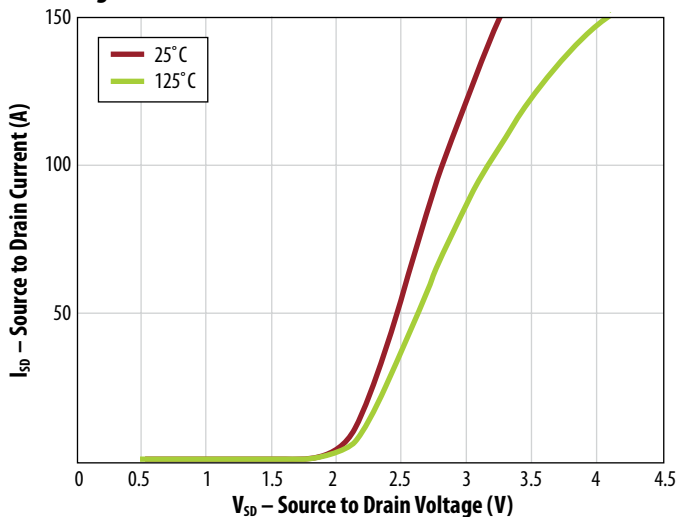


Figure 8: Normalized On Resistance Vs Temperature

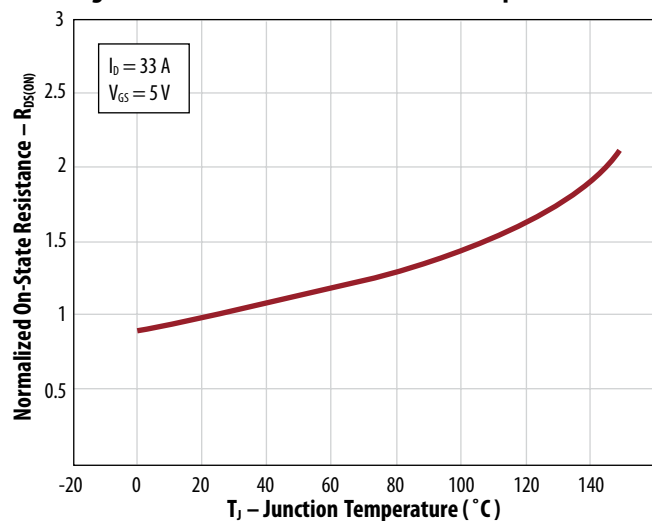


Figure 9: Normalized Threshold Voltage vs. Temperature

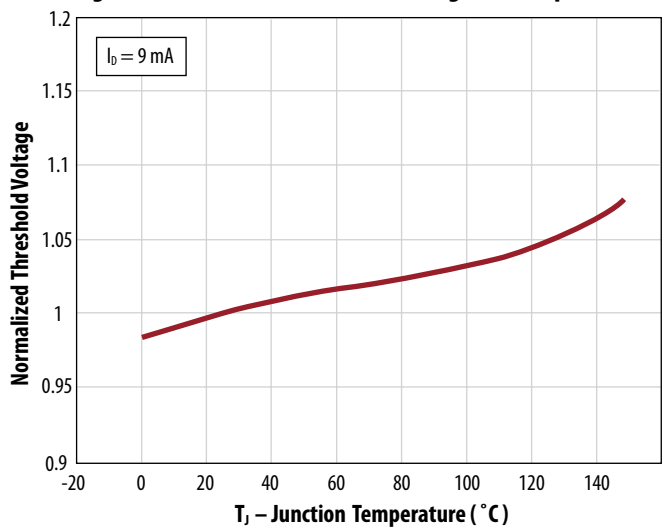
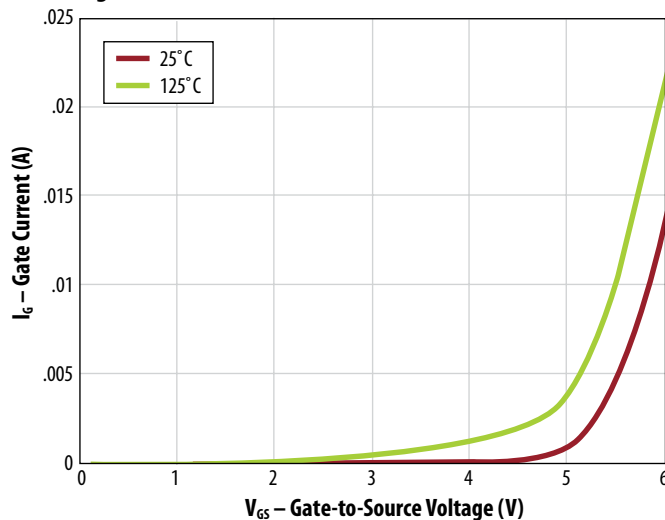


Figure 10: Gate Current



All measurements were done with substrate shorted to source.

Figure 11: Transient Thermal Response Curves

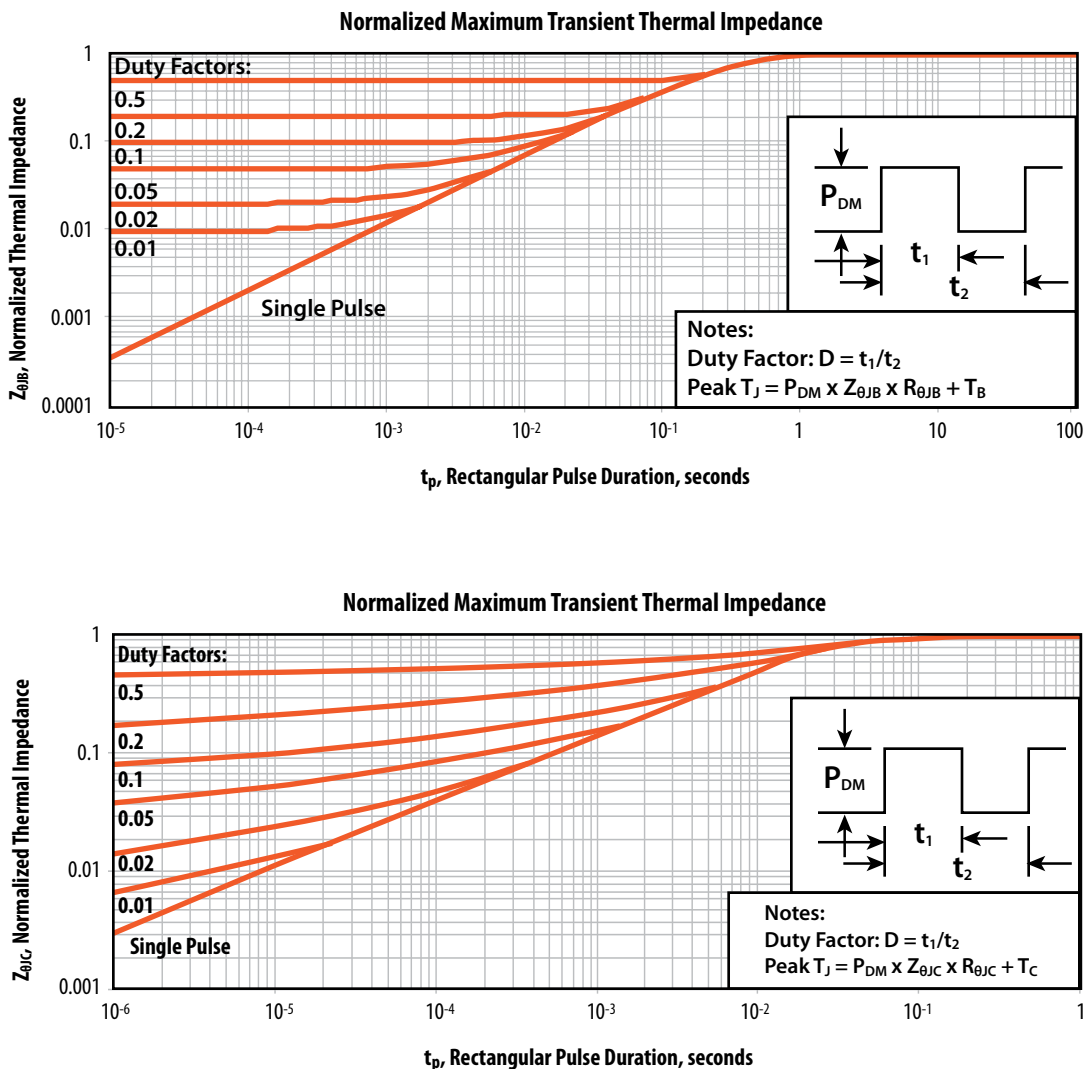
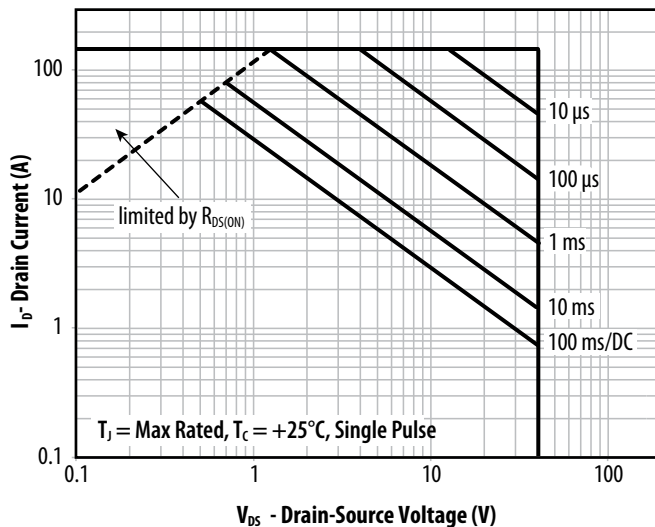
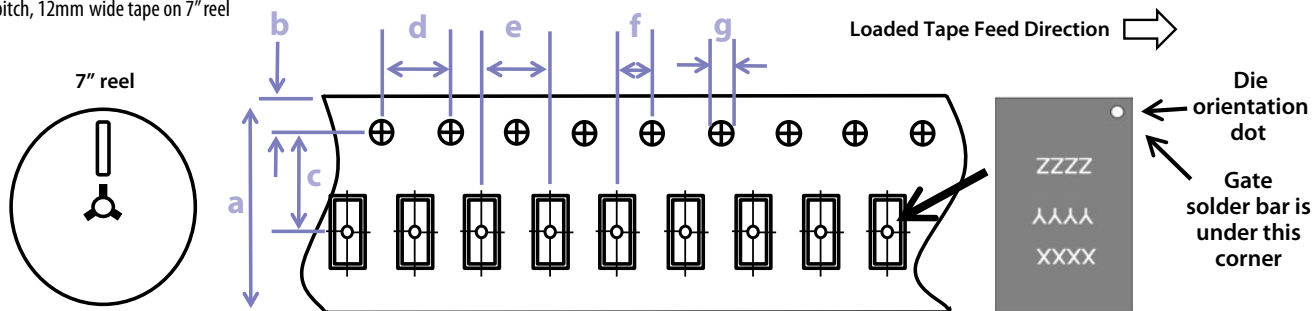


Figure 12: Safe Operating Area



TAPE AND REEL CONFIGURATION

4mm pitch, 12mm wide tape on 7" reel

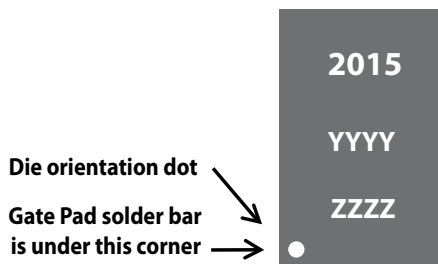


Die is placed into pocket solder bar side down (face side down)

Dimension (mm)	EPC2015 (note 1)		
	target	min	max
a	12.0	11.7	12.3
b	1.75	1.65	1.85
c (note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (note 2)	2.00	1.95	2.05
g	1.5	1.5	1.6

Note 1: MSL1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
 Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

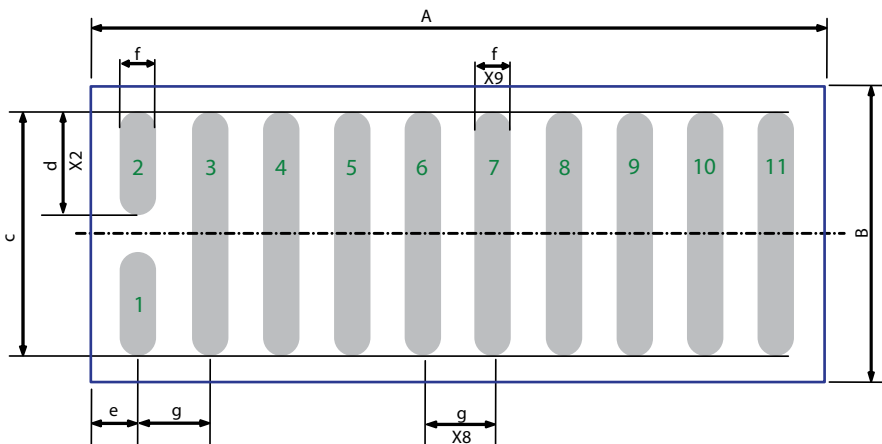
DIE MARKINGS



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking line 2	Lot_Date Code Marking Line 3
EPC2015	2015	YYYY	ZZZZ

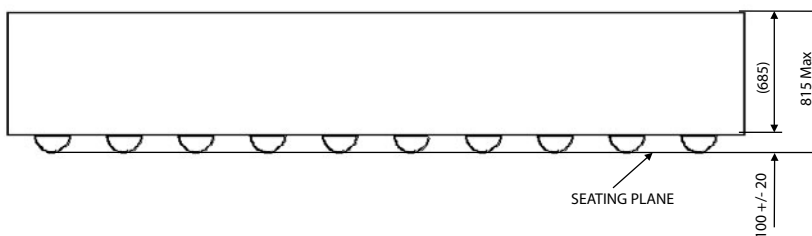
DIE OUTLINE

Solder Bar View



DIM	MICROMETERS		
	MIN	Nominal	MAX
A	4075	4105	4135
B	1602	1632	1662
c	1379	1382	1385
d	577	580	583
e	235	250	265
f	195	200	205
g	400	400	400

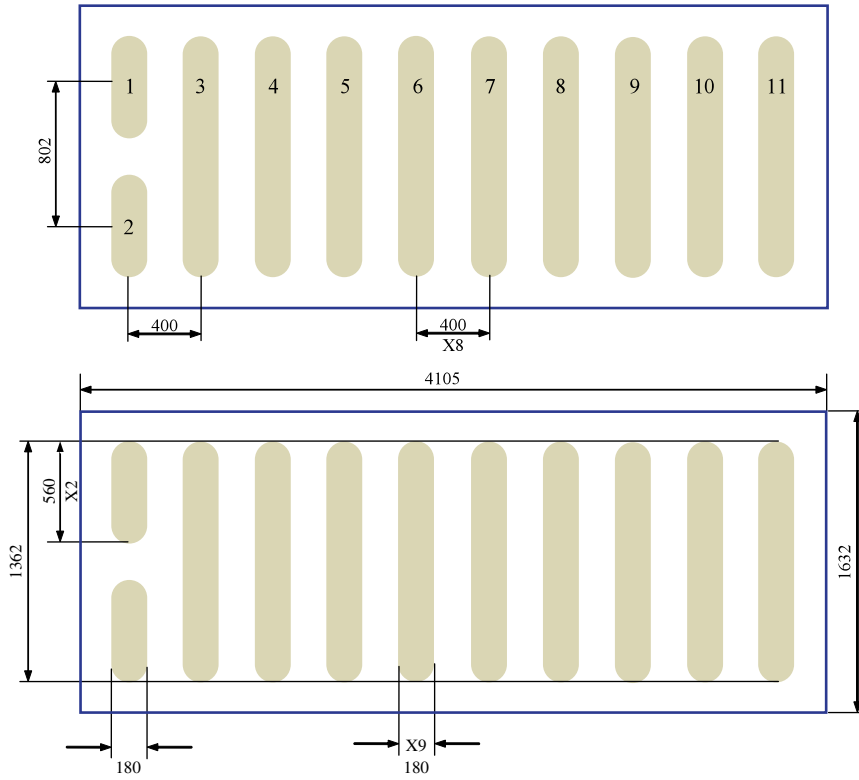
Side View



RECOMMENDED LAND PATTERN

(units in μm)

The land pattern is solder mask defined.



Pad no. 1 is Gate;
 Pads no. 3, 5, 7, 9, 11 are Drain;
 Pads no. 4, 6, 8, 10 are Source;
 Pad no. 2 is Substrate.

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Revised January, 2013

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